

AUIRFR/U024N

Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	55			V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.052		V/°C	Reference to 25°C, I_D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.075	Ω	V _{GS} = 10V, I _D = 10A ④
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	V _{DS} = V _{GS} , I _D = 250μA
gfs	Forward Trans conductance	4.5			S	V _{DS} = 25V, I _D = 10A ⑥
I _{DSS}	Drain-to-Source Leakage Current			25	μA	V _{DS} = 55 V, V _{GS} = 0V
				250		V _{DS} = 44V,V _{GS} = 0V,T _J =150°C
I _{GSS}	Gate-to-Source Forward Leakage Gate-to-Source Reverse Leakage			100	5	V _{GS} = 20V
				-100	nA	V _{GS} = -20V

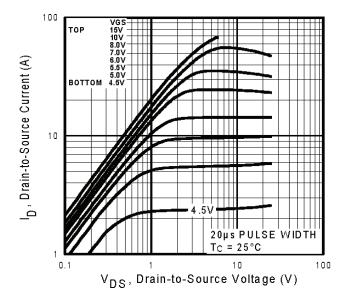
Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	0 • · · ·		•					
Q _g	Total Gate Charge			20		I _D = 10A		
Q_{gs}	Gate-to-Source Charge			5.3	nC	$V_{DS} = 44V$		
Q _{gd}	Gate-to-Drain Charge			7.6		V_{GS} = 10V, See Fig 6 and 13 \oplus (6)		
t _{d(on)}	Turn-On Delay Time		4.9			V _{DD} = 28V		
t _r	Rise Time		34		-	I _D = 10A		
t _{d(off)}	Turn-Off Delay Time		19		ns	$R_{G} = 24\Omega$		
t _f	Fall Time		27			R _D = 2.6Ω, See Fig 10 ④⑥		
L _D	Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)		
L _S	Internal Source Inductance		7.5		1111	from package and center of die contact (5)		
C _{iss}	Input Capacitance		370			V _{GS} = 0V		
C _{oss}	Output Capacitance		140		pF	V _{DS} = 25V		
C _{rss}	Reverse Transfer Capacitance		65			f = 1.0MHz, See Fig. 5		
Diode Cha	racteristics							
	Parameter	Min.	Тур.	Max.	Units	Conditions		
ls	Continuous Source Current (Body Diode)			17⑤		MOSFET symbol showing the		
I _{SM}	Pulsed Source Current (Body Diode) ①			68	A	integral reverse		
V_{SD}	Diode Forward Voltage			1.3	V	$T_{J} = 25^{\circ}C, I_{S} = 10A, V_{GS} = 0V$ (4)		
t _{rr}	Reverse Recovery Time		56	83	ns	T _J = 25°C ,I _F = 10A		
Q _{rr}	Reverse Recovery Charge		120	180	nC	di/dt = 100A/µs ⊕᠖		
t _{on}	Forward Turn-On Time Intrinsic turn-on time is negligible (turn-on is dominated by L _s +L _D)							

Notes:

- $\odot\;$ Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② V_{DD} = 25V, starting T_J = 25°C, L = 1mH, R_G = 25 Ω , I_{AS} = 10A, V_{GS} =10V. (See Fig.12)
- $\label{eq:ISD} \ensuremath{\mathbb{S}} \ensuremath{$
- ④ Pulse width \leq 300µs; duty cycle \leq 2%.
- $\$ This is applied for I-PAK, Ls of D-PAK is measured between lead and center of die contact .
- [©] Uses IRFZ24N data and test conditions.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994





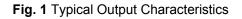


Fig. 3 Typical Transfer Characteristics

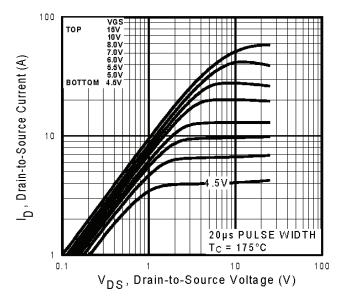


Fig. 2 Typical Output Characteristics

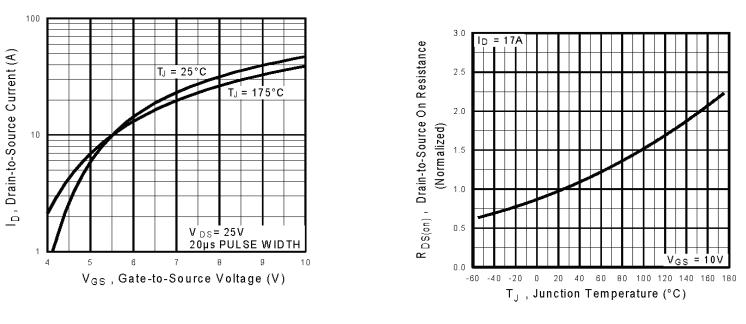
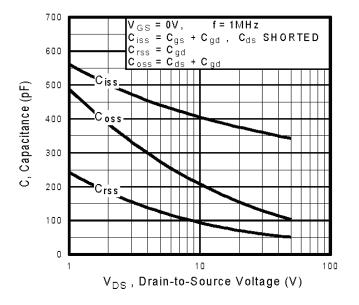
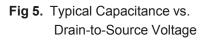


Fig. 4 Normalized On-Resistance vs. Temperature







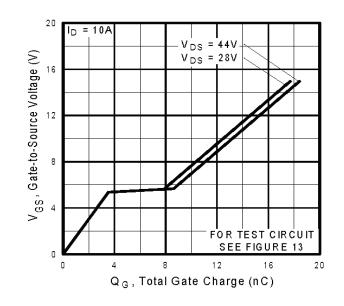


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

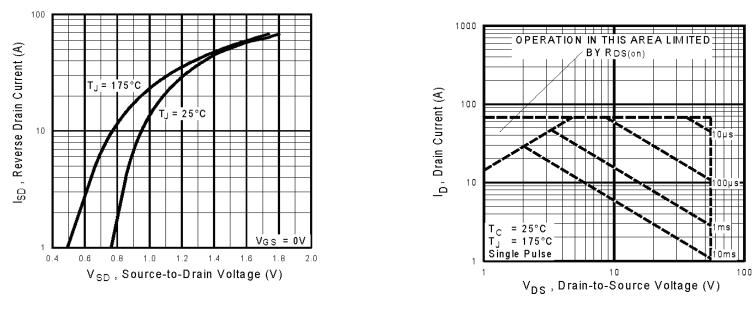


Fig. 7 Typical Source-to-Drain Diode Forward Voltage



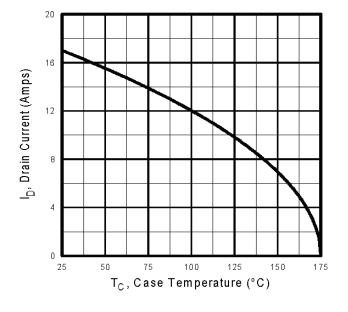


Fig 9. Maximum Drain Current vs. Case Temperature

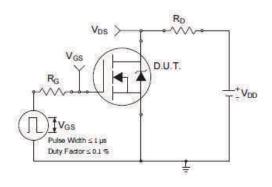


Fig 10a. Switching Time Test Circuit

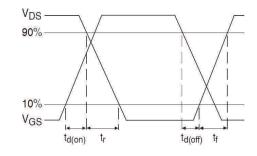


Fig 10b. Switching Time Waveforms

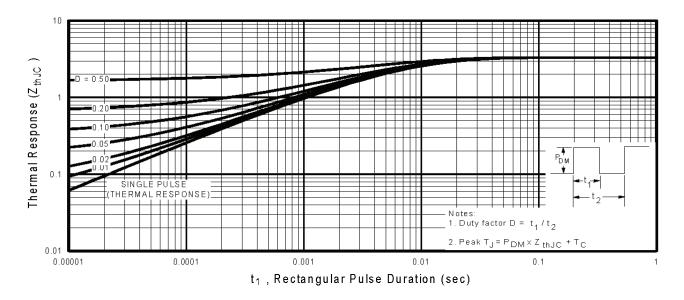


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

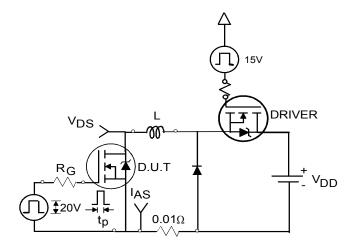


Fig 12a. Unclamped Inductive Test Circuit

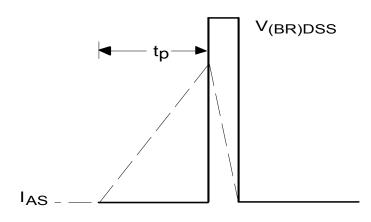
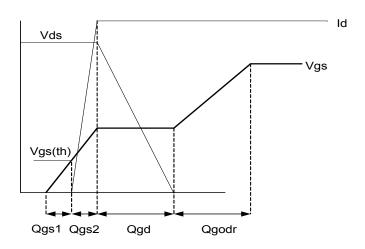


Fig 12b. Unclamped Inductive Waveforms





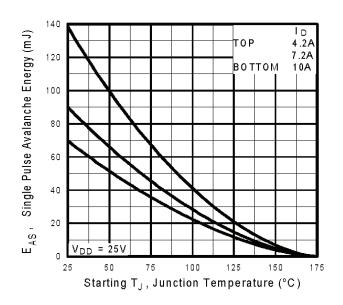


Fig 12c. Maximum Avalanche Energy vs. Drain Current

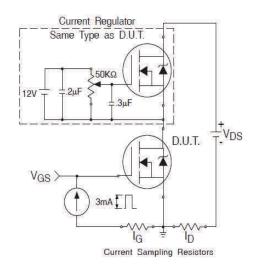
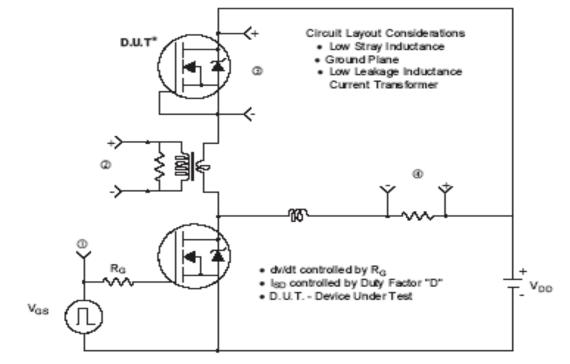


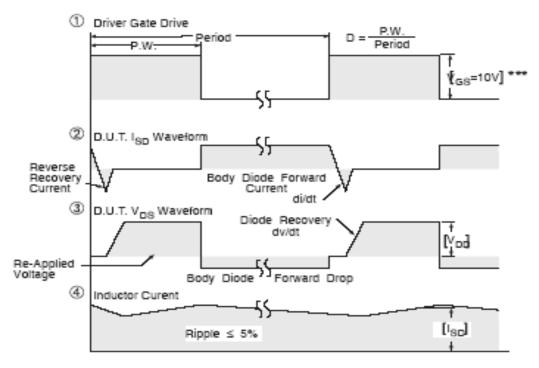
Fig 13b. Gate Charge Test Circuit





Peak Diode Recovery dv/dt Test Circuit

* Reverse Polarity of D.U.T for P-Channel



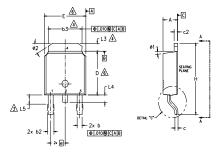
*** VGS = 5.0V for Logic Level and 3V Drive Devices

Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

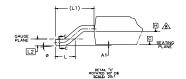


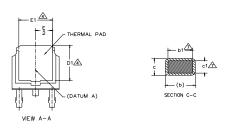
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D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- A- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- ▲ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- A- DATUM A & B TO BE DETERMINED AT DATUM PLANE H. 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S Y M		DIMENSIONS					
B	MILLIM	ETERS	INC	HES	0 T		
0 L	MIN.	MAX.	MIN.	MAX.	ES		
А	2.18	2.39	.086	.094			
A1	-	0.13	-	.005			
b	0.64	0.89	.025	.035			
ь1	0.65	0.79	.025	.031	7		
b2	0.76	1.14	.030	.045			
b3	4.95	5.46	.195	.215	4		
с	0.46	0.61	.018	.024			
c1	0.41	0.56	.016	.022	7		
c2	0.46	0.89	.018	.035			
D	5.97	6.22	.235	.245	6		
D1	5.21	-	.205	-	4		
Е	6.35	6.73	.250	.265	6		
E1	4.32	-	.170	-	4		
е	2.29	BSC	.090	BSC			
Н	9.40	10.41	.370	.410			
L	1.40	1.78	.055	.070			
L1	2.74	BSC	.108	REF.			
L2	0.51	0.51 BSC		.020 BSC			
L3	0.89	1.27	.035	.050	4		
L4	-	1.02	-	.040			
L5	1.14	1.52	.045	.060	3		
ø	0.	10*	0.	10*			
ø1	0.	15 °	0.	15 °			
ø2	25'	35*	25*	35*			

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE 2.- DRAIN 3.- SOURCE

4.- DRAIN

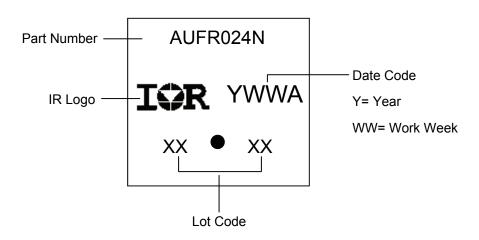
IGBT & CoPAK

1.- GATE

2.- COLLECTOR 3.- EMITTER

4.- COLLECTOR

D-Pak (TO-252AA) Part Marking Information

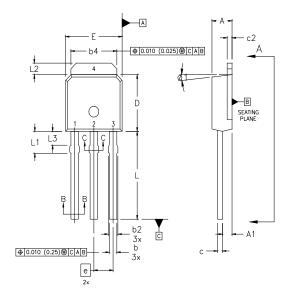


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



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I-Pak (TO-251AA) Package Outline (Dimensions are shown in millimeters (inches)



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994. 1
- 2
- DIMENSION ARE SHOWN IN MILLIMETERS [INCHES]. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY. 3
- THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1. 4 LEAD DIMENSION UNCONTROLLED IN L3. 5
- 6 DIMENSION 61, 63 APPLY TO BASE METAL ONLY.
- OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA. 8
- CONTROLLING DIMENSION : INCHES.

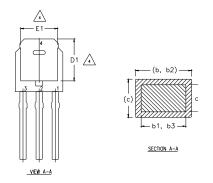
LEAD ASSIGNMENTS

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HEXFET
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1.- GATE

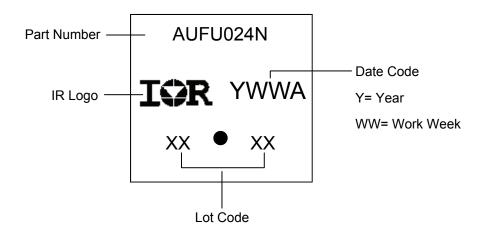
2.- DRAIN 3.- SOURCE





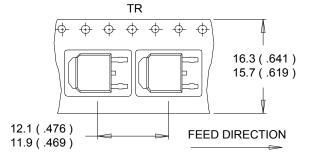
	DIMENSIONS				
SYMBOL	MILLIM	ETERS	INC	HES	
	Min.	MAX.	MIN.	MAX.	NOTES
A	2.18	2.39	0.086	.094	
A1	0.89	1.14	0.035	0.045	
b	0.64	0.89	0.025	0.035	
ь1	0.64	0.79	0.025	0.031	4
b2	0.76	1.14	0.030	0.045	
b3	0.76	1.04	0.030	0.041	
b4	5.00	5.46	0.195	0.215	4
с	0.46	0.61	0.018	0.024	
c1	0.41	0.56	0.016	0.022	
c2	.046	0.86	0.018	0.035	
D	5.97	6.22	0.235	0.245	3, 4
D1	5.21	-	0.205	-	4
E	6.35	6.73	0.250	0.265	3, 4
E1	4.32	-	0.170	-	4
e	2.29		0.090 BSC		
L	8.89	9.60	0.350	0.380	
L1	1.91	2.29	0.075	0.090	
L2	0.89	1.27	0.035	0.050	4
L3	1.14	1.52	0.045	0.060	5
ø1	0.	15	0.	15*	

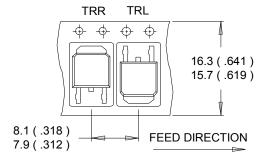
I-Pak (TO-251AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

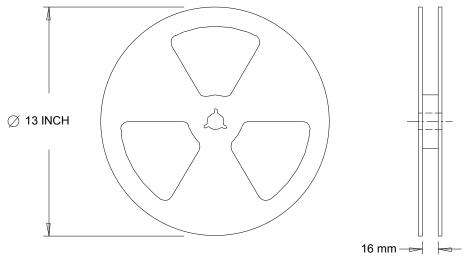
D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))





NOTES :

- 1. CONTROLLING DIMENSION : MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES : 1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

Qualification Level		Automotive (per AEC-Q101)				
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
		D-Pak	MSL1			
woisture	Moisture Sensitivity Level		MISL I			
	Machine Madel	Class M2 (+/- 150V) [†]				
	Machine Model	AEC-Q101-002				
		Class H1A (+/- 500V) [†]				
ESD	Human Body Model	AEC-Q101-001				
		Class C5 (+/- 2000V) [†]				
	Charged Device Model	AEC-Q101-005				
RoHS Compliant		Yes				

+ Highest passing voltage.

Revision History

Date	Comments			
10/12/2015	Updated datasheet with corporate template			
10/12/2013	Corrected ordering table on page 1.			

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